

SWITCHMODE [™] **Series NPN Silicon Power Transistor**

... designed for high current, high speed, high power applications.

• High DC current gain; hFE

min. = 20 at
$$I_C = 6 A$$

• Low V_{CE(sat)}, V_{CE(sat)}

max. =
$$0.6 \text{ V}$$
 at $I_C = 6 \text{ A}$

• Very fast switching times:

$$T_F$$
 max. = 0.8 μ s at I_C = 12 A

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	V _{CEO(sus)}	200	Vdc
Collector-Base Voltage	V _{CBO}	250	Vdc
Emitter-Base Voltage	V _{EBO}	7	Vdc
Collector–Emitter Voltage (V _{BE} = -1.5 V)	V _{CEX}	250	Vdc
Collector–Emitter Voltage ($R_{BE} = 100 \Omega$)	V _{CER}	240	Vdc
Collector–Current— Continuous — Peak (PW ≤ 10 ms)	I _C I _{CM}	20 25	Adc Apk
Base-Current continuous	I _B	4	Adc
Total Power Dissipation @ T _C = 25°C	P _D	150	Watts
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to 200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	θ_{JC}	1.17	°C/W

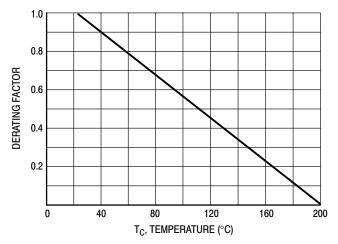


Figure 1. Power Derating

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20 AMPERES
NPN SILICON
POWER
METAL TRANSISTOR
200 VOLTS
150 WATTS



CASE 1-07 TO-204AA (TO-3)

BUV11

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Max	Unit
OFF CHARACTERISTICS					•
Collector–Emitter Sustaining Vo (I _C = 200 mA, I _B = 0, L = 25 r	<u> </u>	V _{CEO(sus)}	200		Vdc
Collector Cutoff Current at Rev $(V_{CE} = 250 \text{ V}, V_{BE} = -1.5 \text{ V})$ $(V_{CE} = 250 \text{ V}, V_{BE} = -1.5 \text{ V}, V_{CE} = -1.5 \text{ V})$		I _{CEX}		1.5 6	mAdc
Collector–Emitter Cutoff Currer (V _{CE} = 160 V)	nt	I _{CEO}		1.5	mAdc
Emitter–Base Reverse Voltage (I _E = 50 mA)		V _{EBO}	7		V
Emitter–Cutoff Current (V _{EB} = 5 V)	I _{EBO}		1.0	mAdc	
SECOND BREAKDOWN					•
Second Breakdown Collector C (V _{CE} = 30 V, t = 1 s) (V _{CE} = 140 V, t = 1 s)	Current with base forward biased	I _{S/b}	5.0 0.15		Adc
ON CHARACTERISTICS ¹		<u>.</u>			•
DC Current Gain ($I_C = 6 \text{ A}, V_{CE} = 2 \text{ V}$) ($I_C = 12 \text{ A}, V_{CE} = 4 \text{ V}$)		h _{FE}	20 10	60	
Collector–Emitter Saturation Vo ($I_C = 6 \text{ A}, I_B = 0.6 \text{ A}$) ($I_C = 12 \text{ A}, I_B = 1.5 \text{ A}$)	oltage	V _{CE(sat)}		0.6 1.5	Vdc
Base–Emitter Saturation Voltage (I _C = 12 A, I _B = 1.5 A)	V _{BE(sat)}		1.5	Vdc	
DYNAMIC CHARACTERISTICS	1				
Current Gain — Bandwidth Product $(V_{CE} = 15 \text{ V, } I_{C} = 1 \text{ A, } f = 4 \text{ MHz})$		f⊤	8.0		MHz
SWITCHING CHARACTERISTIC	CS (Resistive Load)	,		•	•
Turn-on Time		t _{on}		0.8	μs
Storage Time	$(I_C = 12 \text{ A}, I_{B1} = I_{B2} = 1.5 \text{ A}, V_{CC} = 150 \text{ V}, T_C = 12.5 \Omega)$	t _s		1.8	1
Fall Time	v CC = 130 v, 1C = 12.3 22)	t _f		0.4	1

¹ Pulse Test: Pulse Width $\leq 300 \,\mu\text{s}$, Duty Cycle $\leq 2\%$.

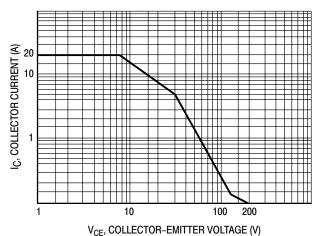


Figure 2. Active Region Safe Operating Area

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C-V_{CE} limits of the transistor that must be observed for reliable operation i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 2 is based on $T_C = 25^{\circ}C$; $T_{J(pk)}$ is variable depending on power level. Second breakdown limitations do not derate the same as thermal limitations.

At high case temperatures, thermal limitations will reduce the power that can handled to values less than the limitations imposed by second breakdown.

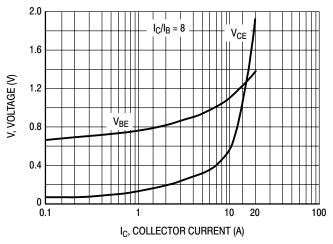


Figure 3. "On" Voltages

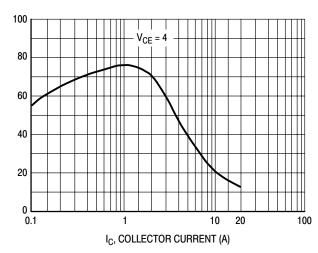


Figure 4. DC Current Gain

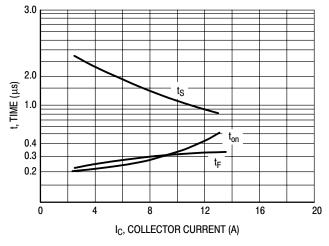
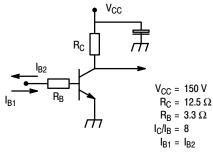


Figure 5. Switching Times versus Collector Current



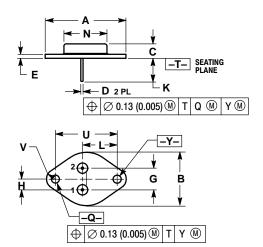
R_C - R_B: Non inductives resistances

Figure 6. Switching Times Test Circuit

BUV11

PACKAGE DIMENSIONS

TO-204AA (TO-3) **CASE 1-07 ISSUE Z**



NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.
- ALL RULES AND NOTES ASSOCIATED WITH REFERENCED TO-204AA OUTLINE SHALL APPLY.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	1.550 REF		39.37 REF		
В		1.050		26.67	
С	0.250	0.335	6.35	8.51	
D	0.038	0.043	0.97	1.09	
Ε	0.055	0.070	1.40	1.77	
G	0.430 BSC		10.92 BSC		
Н	0.215	BSC	5.46 BSC		
K	0.440	0.480	11.18	12.19	
L	0.665 BSC		16.89 BSC		
N		0.830		21.08	
Q	0.151	0.165	3.84	4.19	
O	1.187	BSC	30.15 BSC		
٧	0.131	0.188	3.33	4.77	

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